

# **EMC Test Report**

Report No.: AGC08464190809EE02

**PRODUCT DESIGNATION** : Slot car set

BRAND NAME : N/A

C10269S500, C10269S5M0, C10269X500, C10271S500,

**MODEL NAME** : C10271S5M0, C10271X500, C10281S500, C10281S5M0,

C10281X500

**APPLICANT** : Scale Competition Xtreme S.L.

**DATE OF ISSUE** : Oct. 14, 2019

**STANDARD(S)** Final draft ETSI EN 301 489-1 V2.2.2 (2019-09)

ETSI EN 301 489-3 V2.1.1 (2019-03)

**REPORT VERSION** : V1.0

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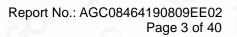
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#### **Report Revise Record**

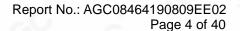
Report Version	Revise Time	Issued Date	Valid Version	Notes
V1.0	1	Oct. 14, 2019	Valid	Initial Release





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1. TEST REPORT CERTIFICATION

1. IESI KEPURI CER	HIFICATION		
Applicant	Scale Competition Xtreme S.L.		
Address Marqués de la Ensenada 14, 1 15 28004 Madrid Spain			
Manufacturer Scale Competition Xtreme S.L.			
Address	Marqués de la Ensenada 14, 1 15 28004 Madrid Spain		
Product Designation	Slot car set		
Brand Name	N/A		
est Model C10269S500			
Series Model C10269S5M0, C10269X500, C10271S500, C10271S5M0, C10271X50 C10281S500, C10281S5M0, C10281X500			
Difference description All the same except for the model name and different appearance color			
Date of test	Oct. 07, 2019 to Oct. 12, 2019		
Deviation	None		
Condition of Test Sample	Normal		
Test Result	Pass		
Report Template AGCRT-EC-EMC			

We, Attestation of Global Compliance (Shenzhen) Co., Ltd., hereby certify that the submitted samples of the above item, as detailed in chapter 2.1 of this report, has been tested in our facility. The test record, data evaluation and test configuration represented herein are true and accurate accounts of measurements of the sample's EMC characteristics under the conditions herein specified.

Prepared By	graven.li	
	Draven Li (Project Engineer)	Oct. 12, 2019
Reviewed By	Max Zhang	
	Max Zhang (Reviewer)	Oct. 14, 2019
Approved By	Forrest on	
	Forrest Lei (Authorized Officer)	Oct. 14, 2019



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#### 2. GENERAL INFORMATION

#### 2.1. DESCRIPTION OF EUT

Details of technical specification refer to the description in follows:

Operating Frequency 2407MHz-2470MHz			
Support Channels	3 Channels		
Modulation	GFSK		
Hardware Version	Transmitter: V1.0 Receiver: V1.0		
Software Version	Transmitter: V1.0 Receiver: V1.0		
Antenna Type	Wire antenna		
Antenna Gain	0dBi		
Receiver category	2		
Power Supply	Transmitter: DC 3.0V by battery Receiver: DC 12V by adapter		
Test Frequency	2407MHz, 2440MHz, 2470MHz		

Model name	DCT12W120050EU-A0
Rated Input	AC100-240V, 50/60Hz, 0.3A max
Rated Output	DC12.0V==0.5A

#### 2.2. OBJECTIVE

Perform Electro Magnetic Interference (EMI) and Electro Magnetic Susceptibility (EMS) tests for CE Marking.

#### 2.3. TEST STANDARDS AND RESULTS

The EUT has been tested according to ETSI EN 301 489-1 V2.2.2 (2019-09) and ETSI EN 301 489-3 V2.1.1 (2019-03).

	Electro Magnetic Compatibility (EMC) standard for radio equipment and services;
ETSI EN 301 489-1	Part 1: Common technical requirements; Harmonised Standard for Electro Magnetic
	Compatibility
	Electro Magnetic Compatibility (EMC) standard for radio equipment and services;
ETSI EN 301 489-3	Part 3: Specific conditions for Short-Range Devices (SRD) operating on frequencies
E 131 EN 301 469-3	between 9 kHz and 246 GHz; Harmonised Standard covering the essential
	requirements of article 3.1(b) of Directive 2014/53/EU

#### 2.4. ENVIRONMENTAL CONDITIONS

During the measurement the environmental conditions were within the listed ranges:

- Temperature: 15-35°C - Humidity: 30-60 %

- Atmospheric pressure: 86-106 kPa



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### 3. TEST MODE DESCRIPTION

NO.	TEST MODE DESCRIPTION	WORST
1	Wireless Communication Mode	V
2	Standby Mode	
Note: 1	. V means EMI worst mode. Only the data of worst case are recorded in th	is report.
2	2. All the modes are tested, but only the worst case is recorded in this repo	rt.

I/O Port Information (⊠Applicable	<b>■Not Applicable</b> )
-----------------------------------	--------------------------

I/O Port of EUT			
I/O Port Type Number Cable Description Tested Wi			Tested With
DC in	1	1.5m Unshielded	1

#### Note:

- 1. All the above "--" means that EUT has no cable.
- 2. All the cables were provided by AGC Lab.



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#### 4. MEASUREMENT UNCERTAINTY

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in measurement" (GUM) published by CISPR and ANSI.

- Uncertainty of Conducted Emission, Uc = ±3.2 dB
- Uncertainty of Radiated Emission below 1GHz, Uc = ±3.9 dB
- Uncertainty of Radiated Emission above 1GHz, Uc = ±4.8 dB





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#### 5. SUPPORT EQUIPMENT

Device Type	Manufacturer	Model Name	Serial No.	specification
0	- CO-	<u></u>	0	, co

#### Note:

1 All the above equipment/cables were placed in worse case positions to maximize emission signals during emission test.





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#### 6. IDENTIFICATION OF THE RESPONSIBLE TESTING LOCATION

Site Attestation of Global Compliance (Shenzhen) Co., Ltd		Attestation of Global Compliance (Shenzhen) Co., Ltd
660	Location	1-2/F, Building 19, Junfeng Industrial Park, Chongqing Road, Heping Community, Fuhai Street, Bao 'an District, Shenzhen, Guangdong, China

#### **TEST EQUIPMENT OF CONDUCTED EMISSION TEST**

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due	
TEST RECEIVER	R&S	ESPI	101206	Jun.12, 2019	Jun.11, 2020	
LISN	R&S	ESH2-Z5	100086	Aug.26, 2019	Aug.25, 2020	

#### **TEST EQUIPMENT OF RADIATED EMISSION TEST**

Equipment Manufacturer		Model	S/N	Cal. Date	Cal. Due
TEST RECEIVER	R&S	ESCI	10096	Jun.12, 2019	Jun.11, 2020
ANTENNA	SCHWARZBECK	VULB9168	494	Jan. 09, 2019	Jan. 08, 2021

#### TEST EQUIPMENT OF POWER HARMONICS / VOLTAGE FLUCTUATION / FLICKER TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due	
Signal Conditioning Unit	Schaffner	CCN1000-1	72431	Aug.26, 2019	Aug.25, 2020	
AC Source	Schaffner	NSG1007	56825	Aug.26, 2019	Aug.25, 2020	

#### **TEST EQUIPMENT OF SURGE/EFT/DIPSTEST**

Description	Manufacture Model		S/N	Cal. Date	Cal. Due	
EFT、Surge Generator	Schaffner	Modula 6150	34437	Aug.26, 2019	Aug.25, 2020	

#### **TEST EQUIPMENT OF ESD TEST**

Equipment	Manufacturer	Manufacturer Model		Cal. Date	Cal. Due	
ESD Simulator	Schaffner	NSG 438	782	Oct.25, 2018	Oct.24, 2019	



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#### **TEST EQUIPMENT OF RS IMMUNITY TEST**

Description	Manufacturer	Model	S/N	Cal. Date	Cal. Due
Signal Generator	R&S	E4421B	MY43351603	Jun. 12, 2019	Jun. 11, 2020
POWER SENSOR	R&S	URV5-Z4	100124	May 17, 2019	May 16, 2020
POWER METER	R&S	NRVD	8323781027	May 17, 2019	May 16, 2020
POWER KALMUS		7100LC	04-02/17-06-001	Jun.12, 2019	Jun.11, 2020
RF AMPLIFIER Milmega		AS0104-55 _55	1004793	Jun.12, 2019	Jun.11, 2020
Double-Ridged Waveguide Horn	ETS LINDGREN	3117	00034609	May. 17, 2019	May. 16, 2021
Broadband Preamplifier	SCHWARZBECK	VULB9168	494	Jan. 09, 2019	Jan. 08, 2021

#### **TEST EQUIPMENT OF CS IMMUNITY TEST**

Description	Manufacturer	Model	S/N	Cal. Date	Cal. Due	
Power Amplifier	AR	75A250	18464	Jun. 12, 2019	Jun. 11, 2020	
CDN	ZHINAN	ZN3751	15004	Sep. 09, 2019	Sep. 08, 2020	
6dB attenuator	ZHINAN	E-002	N/A	Sep. 09, 2019	Sep. 08, 2020	
Electromagnetic Injection Clamp	Luthi	EM101	35773	Oct. 21, 2018	Oct. 20, 2019	
Power Sensor	R&S	URV5-Z4	100124	May 17, 2019	May 16, 2020	
Power Meter	R&S	NRVD	8323781027	May 17, 2019	May 16, 2020	
SIGNAL GENERATOR	R&S	E4421B	MY43351603	Jun. 12, 2019	Jun. 11, 2020	



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#### 7. TEST CONDITIONS AND RESULT

#### 7.1. LINE CONDUCTED EMISSION TEST

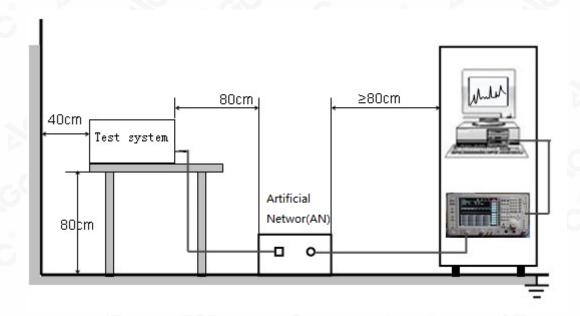
#### 7.1.1 LIMITS OF LINE CONDUCTED EMISSION TEST

Framuonav	Maximum RF Line Voltage					
Frequency	Q.P.( dBuV)	Average( dBuV)				
150kHz-500kHz	66-56	56-46				
500kHz-5MHz	56	46				
5MHz-30MHz	60	50				

#### Note:

- 1. The lower limit shall apply at the transition frequency.
- 2. The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.50MHz.

#### 7.1.2. BLOCK DIAGRAM OF TEST SETUP



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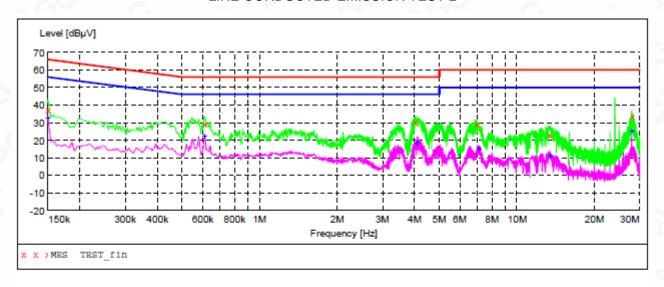
#### 7.1.3. PROCEDURE OF LINE CONDUCTED EMISSION TEST

- (1) The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN 55032 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- (2) Support equipment, if needed, was placed as per EN 55032.
- (3) All I/O cables were positioned to simulate typical actual usage as per EN 55032.
- (4) The EUT received DC power from adapter which received AC 230V power through a Line Impedance Stabilization Network (LISN) which supplied power source and was grounded to the ground plane.
- (5) The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the AN powering the EUT. The AN has two monitoring points: Line 1 (Positive) and Line 2 (Negative). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.
- (6) Analyzer / Receiver scanned from 150 kHz to 30 MHz for emissions in each of the test modes.
- (7) During the above scans, the emissions were maximized by cable manipulation.
- (8) A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions.
- (9) Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. If EUT emission level was less –2dB to the A.V. limit in Peak mode, then the emission signal was re-checked using Q.P and Average detector.



#### 7.1.4. TEST RESULT

#### LINE CONDUCTED EMISSION TEST-L



#### MEASUREMENT RESULT: "TEST fin"

PE
FLO

#### MEASUREMENT RESULT: "TEST fin2"

2	019/10/11 11	:21						
	Frequency	Level	Transd	Limit	Margin	Detector	Line	PE
	MHz	dΒμV	dB	dBµV	dB			
	0.150000	32.70	10.8	56	23.3	AV	L1	FLO
	0.610000	22.60	10.7	46	23.4	AV	L1	FLO
	4.086000	18.20	11.6	46	27.8	AV	L1	FLO
	7.118000	14.90	11.8	50	35.1	AV	L1	FLO
	13.446000	11.20	12.1	50	38.8	AV	L1	FLO
	28.002000	25.20	12.8	50	24.8	AV	L1	FLO

**RESULT: PASS** 

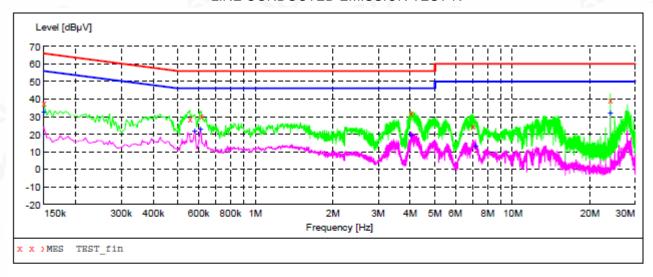


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#### LINE CONDUCTED EMISSION TEST-N



#### MEASUREMENT RESULT: "TEST fin"

2019/10/11	11:29						
Frequen	cy Level Hz dBuV		Limit dBuV	Margin dB	Detector	Line	PE
IV.	нг авич	αв	αвμν	ав			
0.1500	00 37.60	10.8	66	28.4	QP	N	FLO
0.5540	00 28.70	10.9	56	27.3	QP	N	FLO
0.6140	00 30.40	10.7	56	25.6	QP	N	FLO
4.0180	00 32.20	11.6	56	23.8	QP	N	FLO
7.0020	00 24.50	11.8	60	35.5	QP	N	FLO
24.0060	00 39.40	12.7	60	20.6	QP	N	FLO

#### MEASUREMENT RESULT: "TEST fin2"

2019/10/11 1 Frequency MHz	1:29 Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line	PE
0.150000 0.578000 0.610000	32.70 22.00 23.20	10.8 10.8 10.7	56 46 46	23.3 24.0 22.8	AV AV AV	N N N	FLO FLO
4.034000 7.182000 24.002000	19.60 13.50 32.30	11.6 11.8 12.7	46 50 50	26.4 36.5 17.7	AV AV AV	N N N	FLO FLO FLO

#### **RESULT: PASS**



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#### 7.2. RADIATED DISTURBANCE MEASUREMENT

#### 7.2.1. LIMITS OF RADIATED DISTURBANCES

Limits for radiated disturbance 30M to1 GHz at a measurement distance of 3 m

Frequency range (MHz)	Quasi peak limits(dBuV/m), for Class B ITE, at 3m measurement distance
30 - 230	40
230 - 1000	47

#### Limits for radiated disturbance above 1 GHz at a measurement distance of 3 m

Fraguency range (MUT)	Limits (dBuV/m), Class B ITE				
Frequency range (MHz)	Peak	Average			
1000-3000MHz	70	50			
3000-6000MHz	74	54			

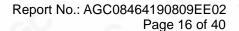
#### Notes

- 1. The lower limit shall apply at the transition frequency.
- 2. Additional provisions may be required for cases where interference occurs.

#### 7.2.2. TEST PROCEDURE

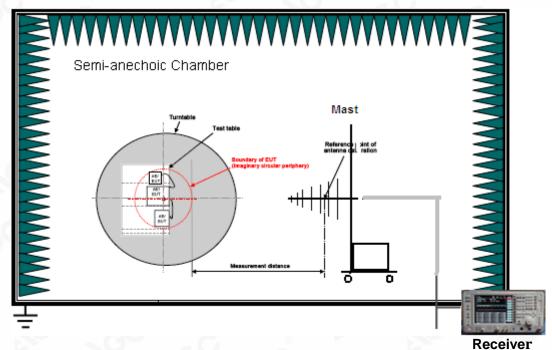
- (1). The EUT was placed on the top of an insulating table 0.8 meters above the ground at a semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- (2). The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- (3). The antenna is a broadband antenna, and its height is varied from 1 to 4 meter above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- (4). For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to the heights from 1 to 4 meters and the ratable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- (5). The test-receiver system was set to Peak Detector Function and Specified Bandwidth with Maximum Hold Mode. If the emission level of the EUT in peak mode was 10dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emission that did not have 10dB margin would be retested one by one using the quasi-peak method.







#### 7.2.3. BLOCK DIAGRAM OF TEST SETUP



For the actual test configuration, please refer to the related item-Photographs of the Test Configuration.

#### 7.2.4 TEST RESULT

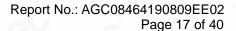
The test modes were carried out for all modes.

The worst test mode of the EUT was Mode 1, and its test data was showed as the follow:



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#### RADIATED EMISSION BELOW 1GHZ-HORIZONTAL



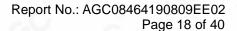
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	68.8000	33.24	12.43	40.00	6.76	100	126	Horizontal
2	145.4300	33.94	14.88	40.00	6.06	200	241	Horizontal
3	190.0500	33.55	12.53	40.00	6.45	100	111	Horizontal
4	292.8700	39.39	16.04	47.00	7.61	200	353	Horizontal
5	482.0200	38.12	21.77	47.00	8.88	100	359	Horizontal
6	782.7200	42.21	28.03	47.00	4.79	100	215	Horizontal

**RESULT: PASS** 



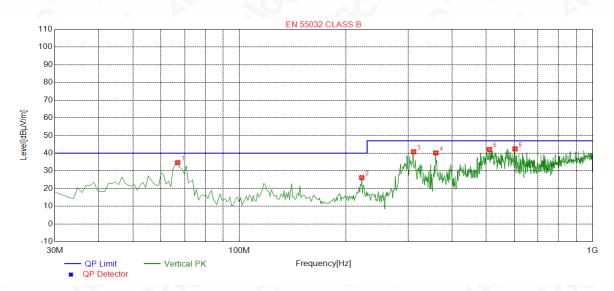
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#### RADIATED EMISSION BELOW 1GHZ- VERTICAL



NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	66.8600	34.67	12.76	40.00	5.33	100	45	Vertical
2	222.0600	26.18	13.44	40.00	13.82	100	0	Vertical
3	311.3000	40.81	16.33	47.00	6.19	100	248	Vertical
4	359.8000	40.16	18.20	47.00	6.84	100	248	Vertical
5	510.1500	42.09	22.38	47.00	4.91	100	59	Vertical
6	603.2700	42.45	24.37	47.00	4.55	100	73	Vertical

#### **RESULT: PASS**

Remark: which 1GHz-6GHz are attenuated more than 20dB below the permissible limits or the field strength is too small to be measured.





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#### 7.3. HARMONIC CURRENT MEASUREMENT

#### 7.3.1 LIMITS OF HARMONIC CURRENT

	Limits for Class A Equipment
Harmonics Order n	Max. permissible harmonic current (A)
	Odd harmonics
3	2.30
5	1.14
7	0.77
9	0.40
11	0.33
13	0.21
15≤n≤39	0.15×15/n
G ®	
2	1.08
4	0.43
6	0.30
8≤n≤40	0.23×8/n

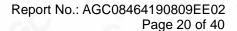
#### Note:

- 1. According to section 5 of EN61000-3-2: 2014, the EUT is Class A equipment.
- 2. The above limits are for all applications having an active input power>75W. No limits apply for equipment with an active input power up to and including 75W.

#### 7.3.2 TEST PROCEDURE

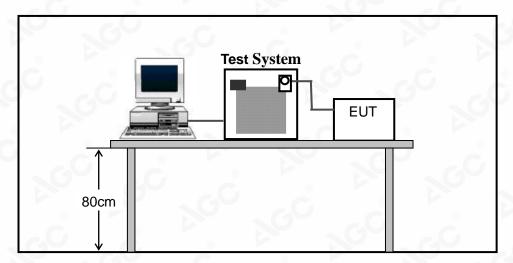
- 1. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- 2. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the necessary for the EUT to be exercised.







#### 7.3.3 TEST SETUP



For the actual test configuration, please refer to Appendix II: Photographs of the Test Configuration.

#### 7.3.4 TEST RESULT

No limits apply for equipment with an active input power up to and including 75W.



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#### 7.4. VOLTAGE FLUCTUATIONS AND FLICK MEASUREMENT

#### 7.4.1 LIMITS OF VOLTAGE FLUCTUATIONS AND FLICK

Test Item	Limit	Note
P <sub>st</sub>	1.0	P <sub>st</sub> means Short-term flicker indicator
Plt	0.65	P <sub>lt</sub> means long-term flicker indicator
T <sub>dt</sub>	0.5	T <sub>dt</sub> means maximum time that d <sub>t</sub> exceeds 3%
d <sub>max</sub> (%)	4%	d <sub>max</sub> means maximum relative voltage change.
d <sub>c</sub> (%)	3.3%	d <sub>c</sub> means relative steady-state voltage change.

#### 7.4.2 TEST PROCEDURE

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal conditions
- b. During the flick measurement, the measure time shall include that part of whole operation changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

#### 7.4.3 TEST SETUP

Same as 3.4.3

#### 7.4.4 TEST RESULT

#### **Test Specification**

Test Frequency	50Hz	Test Voltage	AC 230V
Waveform	Sine	Test Time	10 minutes(P <sub>st</sub> ); 2 hours (P <sub>lt</sub> )

#### **Test Result**

#### **⋈ MODE 1 ⋈ MODE 2**

Test Parameter	Measurement Value	Limit	Remarks
P <sub>st</sub>	0.75	1.0	Pass
P <sub>lt</sub>	0.32	0.65	Pass
T <sub>dt(s)</sub>	0.21	0.5	Pass
d <sub>max</sub> (%)	1.862%	4%	Pass
d <sub>c</sub> (%)	0.966%	3.3%	Pass





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#### 8. IMMUNITY TEST

#### 8.1. EUT SETUP AND OPERATING CONDITIONS

The charger was connected to the EUT to keep the voltage constant during the tests. Each immunity test was performed according to the requirements of the standard.

#### 8.2. GENERAL PERFORMANCE CRITERIA

#### 1. Performance criteria for Continuous phenomena

During the test, the equipment shall:

- continue to operate as intended;
- · not unintentionally transmit;
- · not unintentionally change its operating state;
- · not unintentionally change critical stored data.

#### 2. Performance criteria for Transient phenomena

For all ports and transient phenomena with the exception described below, the following applies:

- The application of the transient phenomena shall not result in a change of the mode of operation (e.g. unintended transmission) or the loss of critical stored data.
- After application of the transient phenomena, the equipment shall operate as intended.

For surges applied to symmetrically operated wired network ports intended to be connected directly to outdoor lines the following criteria applies:

- For products with only one symmetrical port intended for connection to outdoor lines, loss of function is allowed, provided the function is self-recoverable, or can be otherwise restored. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.
- For products with more than one symmetrical port intended for connection to outdoor lines, loss of function on the port under test is allowed, provided the function is self-recoverable. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

#### 3. Performance Table

	Perforn	nance criteria
Criteria	During Test	After Test
А	Operate as intended No loss of function No unintentional responses	Operate as intended No loss of function No degradation of performance No loss of stored data or user programmable functions
В	May show loss of function No unintentional responses	Operate as intended Lost function(s) shall be self-recoverable No degradation of performance No loss of stored data or user programmable functions



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#### 8.3. ELECTROSTATIC DISCHARGE IMMUNITY TEST

#### 8.3.1 TEST SPECIFICATION

Basic Standard	EN 61000-4-2
Discharge Impedance	330Ω / 150 pF
Discharge Voltage	Air Discharge:8 kV , Contact Discharge:4 kV
Polarity	Positive / Negative
Number of Discharge	Minimum 20 times at each test point
Discharge Mode	Single discharge
Discharge Period	1-second minimum

#### **8.3.2 TEST PROCEDURE**

The test procedure was in accordance with EN 61000-4-2:

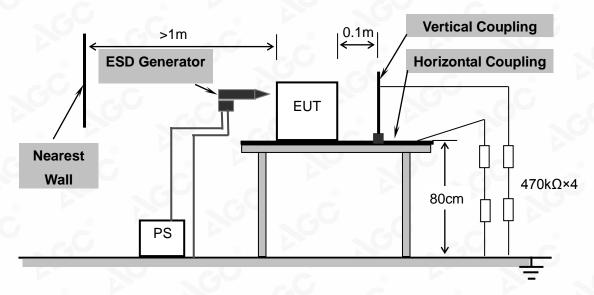
- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were completed.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the EUT. The ESD generator was positioned vertically at a distance of 0.1 meters from the EUT with the discharge electrode touching the HCP.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5m×0.5m) was placed vertically to and 0.1 meters from the EUT.





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#### 8.3.3 TEST SETUP



For the actual test configuration, please refer to Appendix II: Photographs of the Test Configuration.

## 8.3.4 TEST RESULT TEST PROCEDURE

Please refer to ETSI EN 301 489-1 Clause 9.3.2 and EN 61000-4-2 for the measurement methods.

#### ⊠ MODE 1 ⊠ MODE 2

M mode : M mode z	_				(6)
Amount of Discharges	Voltage	Coupling	Observation during Test	Observation after Test	Criteria
Mini 20 / Point	±2kV;±4kV	contact discharge	Note 1	Note 2	Α
Mini 20 / Point	±2kV;±4kV;±8kV	Air Discharge	Note 1	Note 2	Α
Mini 20 / Point	±4kV	Indirect Discharge HCP	Note 1	Note 2	Α
Mini 20 / Point	±4kV	Indirect Discharge VCP	Note 1	Note 2	Α

Note 1: Operate as intended; No loss of function; No unintentional responses.

Note 2: Operate as intended; No loss of function; No degradation of performance; No loss of stored data or user programmable functions.

Note 3: Loss of function(s); No unintentional responses.

Note 4: Operate as intended; Lost function(s) had been self-recoverable;

No degradation of performance; No loss of stored data or user programmable functions.



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# 8.4. RADIATED, RADIO FREQUENCY ELECTROMAGNETIC FIELD IMMUNITY TEST 8.4.1 TEST SPECIFICATION

4-3 6000MHz
6000MHz
wave, 80%, AM modulation
lamental
and Vertical
00 -0 0 0
l

#### **8.4.2 TEST PROCEDURE**

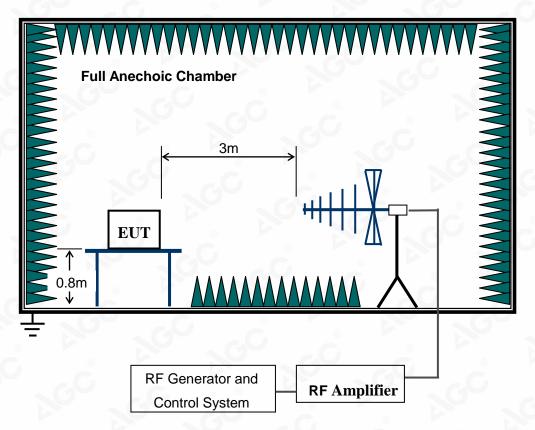
The test procedure was in accordance with EN 61000-4-3.

- a. The testing was performed in a fully anechoic chamber. The transmit antenna was located at a distance of 3 meters from the EUT.
- b. The test signal was 80% amplitude modulated with a 1 kHz sine wave.
- c. The frequency range was swept from 80 MHz to 6000MHz with the exception of the exclusion band for transmitters, receivers and duplex transceivers. The rate of sweep did not exceed 1.5×10<sup>-3</sup> decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- d. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- e. The field strength level was 3V/m.
- f. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.





#### 8.4.3 TEST SETUP



For the actual test configuration, please refer to Appendix II: Photographs of the Test Configuration.



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## 8.4.4 TEST RESULT TEST PROCEDURE

Please refer to ETSI EN 301 489-1 Clause 9.2.2, ETSI EN 301 489-3 and EN 61000-4-3 for the measurement methods.

#### ⊠ MODE 1 ⊠ MODE 2

MINOPE I MINO	UL Z						
Freq. Range (MHz)	Field	Modulation	Polarity	Position	Observation during Test	Observation after Test	Criteria
80-6000	3V/m	Yes	Н	Front	Note 1	Note 2	Α
80-6000	3V/m	Yes	н	Back	Note 1	Note 2	Α
80-6000	3V/m	Yes	Н	Left	Note 1	Note 2	А
80-6000	3V/m	Yes	Н	Right	Note 1	Note 2	Α
80-6000	3V/m	Yes	V	Front	Note 1	Note 2	А
80-6000	3V/m	Yes	٧	Back	Note 1	Note 2	Α
80-6000	3V/m	Yes	V	Left	Note 1	Note 2	Α
80-6000	3V/m	Yes	V	Right	Note 1	Note 2	А

Note 1: Operate as intended; No loss of function; No unintentional responses.

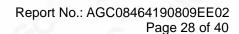
Note 2: Operate as intended; No loss of function; No degradation of performance; No loss of stored data or user programmable functions.

Note 3: Loss of function(s); No unintentional responses.

Note 4: Operate as intended; Lost function(s) had been self-recoverable;

No degradation of performance; No loss of stored data or user programmable functions.







#### 8.5. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

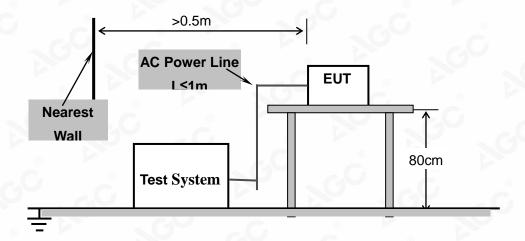
#### 8.5.1 TEST SPECIFICATION

Basic Standard	EN 61000-4-4
Test Voltage	a.c. power port :1 kV
Polarity	Positive/Negative
Impulse Frequency	5kHz
Impulse wave shape	5/50ns
<b>Burst Duration</b>	15ms
Burst Period	300ms
Test Duration	Not less than 1 min.

#### **8.5.2 TEST PROCEDURE**

- a. The EUT was tested with 1000 volt discharges to the AC power input leads.
- b. Both positive and negative polarity discharges were applied.
- c. The length of the "hot wire" from the coaxial output of the EFT generator to the terminals on the EUT should not exceed 1 meter.
- d. The duration time of each test sequential was 1 minute.
- e. The transient/burst waveform was in accordance with EN 61000-4-4, 5/50ns.

#### 8.5.3 TEST SETUP



For the actual test configuration, please refer to Appendix II: Photographs of the Test Configuration.



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#### 8.5.4 TEST RESULT

Test Point	Polarity	Test Level (kV) Observation during Test		Observation after Test	Criteria	
a.c. port, L	+/-	1	Note 1	Note 2	Α	
a.c. port, N	+/-	1	Note 1	Note 2	Α	
a.c. port, L-N	+/-	1 60	Note 1	Note 2	Α	
a.c. port, L-N	+/-	。 1	Note 1	Note 2	Α	

Note 1: Operate as intended; No loss of function; No unintentional responses.

Note 2: Operate as intended; No loss of function; No degradation of performance; No loss of stored data or user programmable functions.

Note 3: Loss of function(s); No unintentional responses.

Note 4: Operate as intended; Lost function(s) had been self-recoverable;

No degradation of performance; No loss of stored data or user programmable functions.





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#### **8.6. SURGE IMMUNITY TEST**

#### **8.6.1 TEST SPECIFICATION**

Basic Standard	EN 61000-4-5
Waveform	Voltage 1.2/50 μs; Current 8/20 μs
Test Voltage	a.c. power port, line to ground 2 kV, line to line 1.0 kV
Polarity	Positive/Negative
Phase Angle	0°, 90°, 180°, 270°
Repetition Rate	60sec
Times	5 time/each condition.

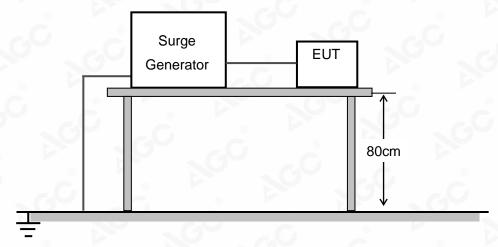
#### **8.6.2 TEST PROCEDURE**

- a. The EUT and the auxiliary equipment were placed on a table of 0.8m heights above a metal ground reference plane. The size of ground plane is greater than 1mx1m and project beyond the EUT by at least 0.1m on all sides. The ground plane is connected to the protective earth. The length of power cord between the coupling device and the EUT was less than 2 meters (provided by the manufacturer).
- b. The EUT was connected to the power mains through a coupling device that directly couples the surge interference signal. The surge noise was applied synchronized to the voltage phase at the zero crossing and the peak value of the AC voltage wave (positive and negative).
- c. The surges were applied line to line and line(s) to earth. When testing line to earth the test voltage was applied successively between each of the lines and earth. Steps up to the test level specified increased the test voltage. All lower levels including the selected test level were tested. The polarity of each surge level included positive and negative test pulses.





#### 8.6.3 TEST SETUP



For the actual test configuration, please refer to Appendix II: Photographs of the Test Configuration.





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#### 8.6.4 TEST RESULT

#### MODE 1 MODE 2

Coupling Line	Polarity	Test Level (kV)	Observation during Test	Observation after Test	Criteria
a.c. power, L-N	+/-	1	Note 1	Note 2	Α

Note 1: Operate as intended; No loss of function; No unintentional responses.

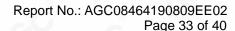
Note 2: Operate as intended; No loss of function; No degradation of performance; No loss of stored data or user programmable functions.

Note 3: Loss of function(s); No unintentional responses.

Note 4: Operate as intended; Lost function(s) had been self-recoverable;

No degradation of performance; No loss of stored data or user programmable functions.







#### 8.7. IMMUNITY TO CONDUCTED DISTURBANCES INDUCED BY RF FIELDS

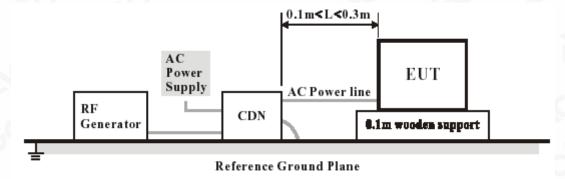
#### 8.7.1 TEST SPECIFICATION

Basic Standard	EN 61000-4-6
Frequency Range	0.15 MHz – 80 MHz
Field Strength	3Vrms
Modulation	1 kHz Sine Wave, 80% AM
Frequency Step	1% of fundamental
Coupled Cable	a.c. power line
Coupling Device	CDN-M2

#### **8.7.2 TEST PROCEDURE**

- The EUT shall be tested within its intended operating and climatic conditions.
- b. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn, while the other non-excited RF input ports of the coupling devices are terminated by a 50-ohm load resistor.
- c. The test signal was 80% amplitude modulated with a 1 kHz sine wave
- d. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80% amplitude. The sweep rate shall not exceed 1.5×10<sup>-3</sup> decades/s. The step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value where the frequency is swept incrementally.
- e. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies such as clock frequencies and harmonics or frequencies of dominant interest, shall be analyzed separately.
- f. Attempts should be made to fully exercise the EUT during test, and to fully interrogate all exercise modes selected for susceptibility.

#### 8.7.3 TEST SETUP



For the actual test configuration, please refer to Appendix II: Photographs of the Test Configuration.



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#### 8.7.4 TEST RESULT

#### MODE 1 MODE 2

Test Point	Frequency (MHz)	Field Strength (Vrms)	Observation during Test	Observation after Test	Criteria
a.c. port	0.15 – 80	3	Note 1	Note 2	Α

Note 1: Operate as intended; No loss of function; No unintentional responses.

Note 2: Operate as intended; No loss of function; No degradation of performance; No loss of stored data or user programmable functions.

Note 3: Loss of function(s); No unintentional responses.

Note 4: Operate as intended; Lost function(s) had been self-recoverable;

No degradation of performance; No loss of stored data or user programmable functions.





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#### 8.8. VOLTAGE DIPS AND SHORT INTERRUPTIONS IMMUNITY TEST

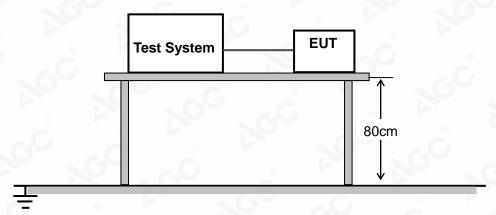
#### 8.8.1 TEST SPECIFICATION

Basic Standard	EN 61000-4-11
Voltage Dips	100% reduction, 0.5 Cycle 100% reduction, 1.0 Cycle 30% reduction, 25 Cycles
Voltage Interruptions	100% reduction, 250 Cycles
Voltage Phase Angle	0°, 45°, 90°, 135°, 180°, 225°, 270°, 315°

#### **8.8.2 TEST PROCEDURE**

- a. The power cord was used as supplied by the manufacturer. The EUT was connected to the line output of the Voltage Dips and Interruption Generator.
- b. The EUT was tested for (1) 100% voltage dip of supplied voltage with duration of 0.5 cycles, (2)100% voltage dip of supplied voltage and duration 1.0 cycle. (3) 30% voltage dip of supplied voltage and duration 25 cycles. (4) 100% voltage interruption of supplied voltage with duration of 250 Cycles was followed.
- c. Voltage reductions occur at 0 degree crossover point of the voltage waveform. The performance of the EUT was checked after the voltage dip or interruption.

#### 8.8.3 TEST SETUP



For the actual test configuration, please refer to Appendix II: Photographs of the Test Configuration.





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#### 8.8.4 TEST RESULT

⊠ MODE 1 ⊠ MODE 2

MICOL I	MODEL						
Test Mode	Voltage Reduction	Duration (cycle)	Times	Interval (Sec)	Observation during Test	Observation after Test	Criteria
~G <sup>C</sup>	100%	0.5	3	10	Note 1	Note 2	Α
Voltage dips	100%	1	3	10	Note 1	Note 2	Α
	30%	25	3	10	Note 1	Note 2	Α
Voltage interruptions	100%	250	3	10	Note 3	Note 4	В

Note 1: Operate as intended; No loss of function; No unintentional responses.

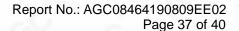
Note 2: Operate as intended; No loss of function; No degradation of performance; No loss of stored data or user programmable functions.

Note 3: Loss of function(s); No unintentional responses.

Note 4: Operate as intended; Lost function(s) had been self-recoverable;

No degradation of performance; No loss of stored data or user programmable functions





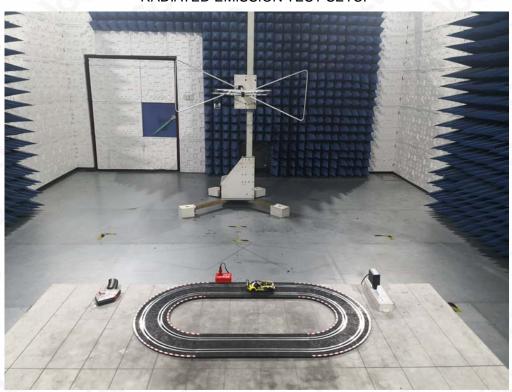


#### APPENDIX A: PHOTOGRAPHS OF TEST SETUP

LINE CONDUCTED EMISSION TEST SETUP



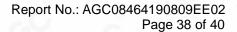
RADIATED EMISSION TEST SETUP





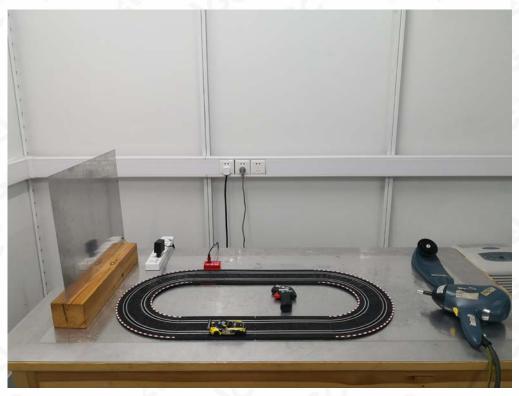
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#### EN 61000-4-2 ESD TEST SETUP



EN61000-3-3 VOLTAGE FLUCTUATION / FLICKER TEST SETUP

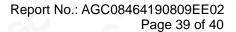




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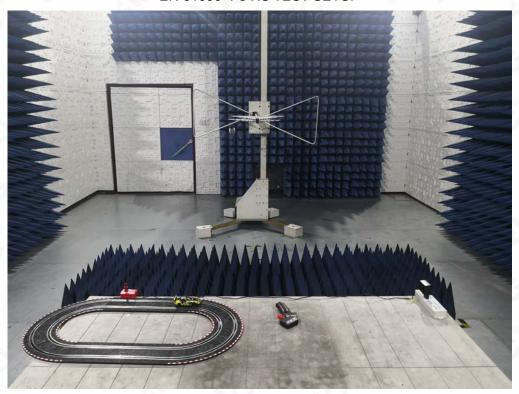
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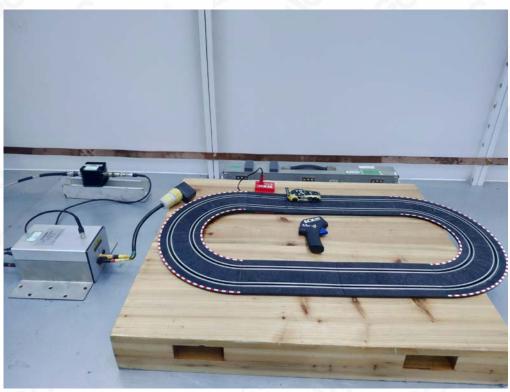




#### EN 61000-4-3 RS TEST SETUP



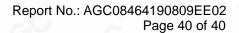
EN 61000-4-6 CS IMMUNITY TEST SETUP





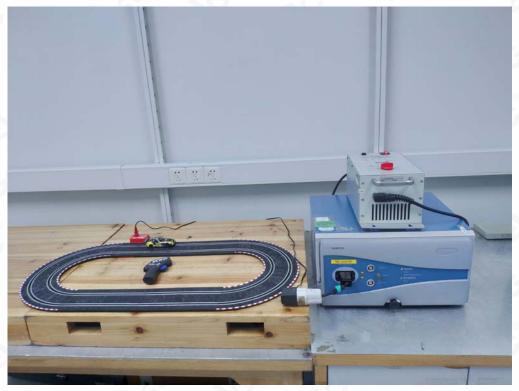
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#### EN 61000-4-4/-5/-11 EFT/SURGE/DIPS TEST SETUP



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